Search	Notes

-	Application No.	Applicant(s)	
	10/780,859	ENDO, HIRONO	ORI
	Examiner	Art Unit	
	Julian D. Huffman	2853	

	SEAR	CHED	
Class	Subclass	Date	Examiner
347	19	9/28/2004	JH
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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		DATE	EXMR
347/19.ccls. and ((droplet dot) (size diameter radius)) same ( patch sample test correction)	with pattern	9/28/2004	JH
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